FIG. 1

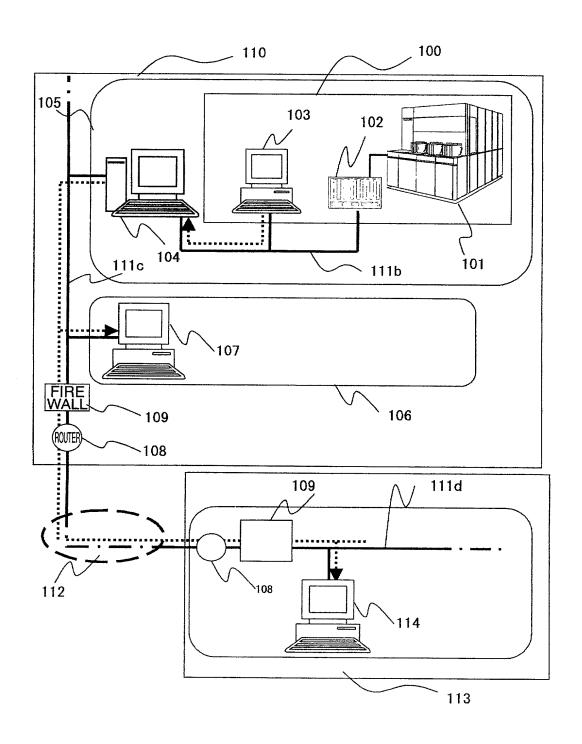


FIG. 2

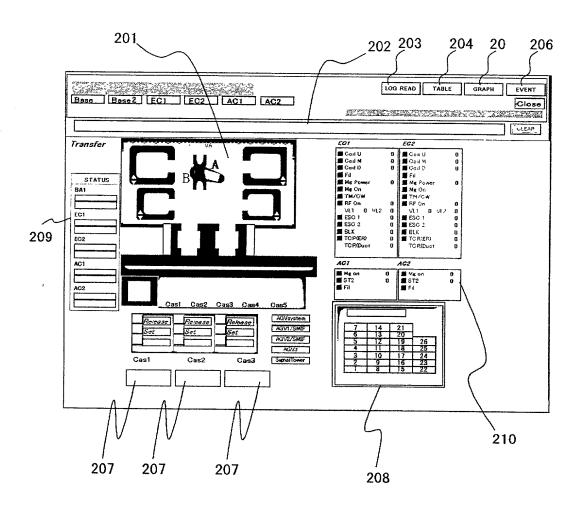
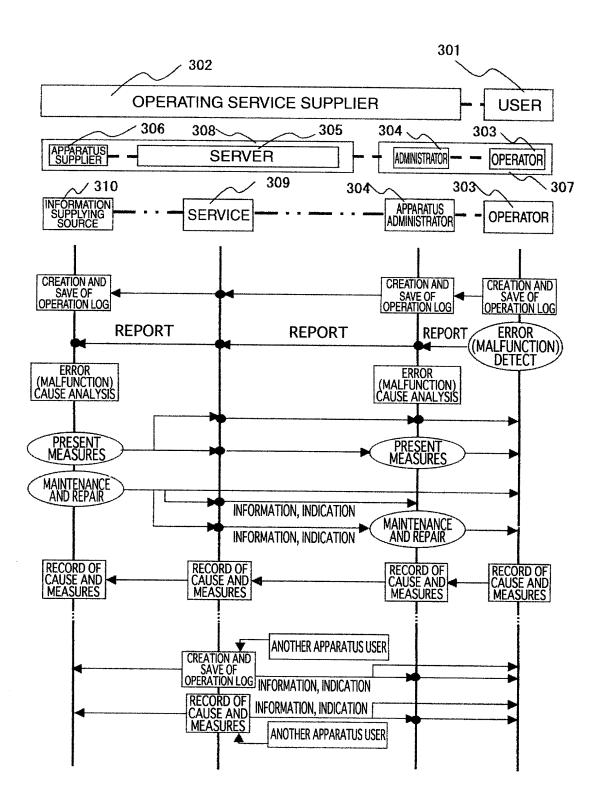
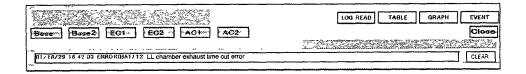


FIG. 3



## FIG. 4A



## FIG. 4B

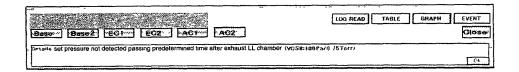
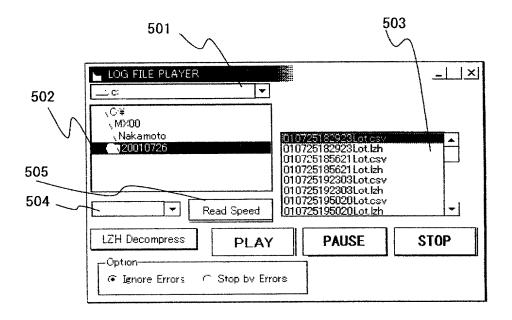


FIG. 5



ERIOLES AND SELECTION OF SELECTION CONTRACTORS

FIG. 6

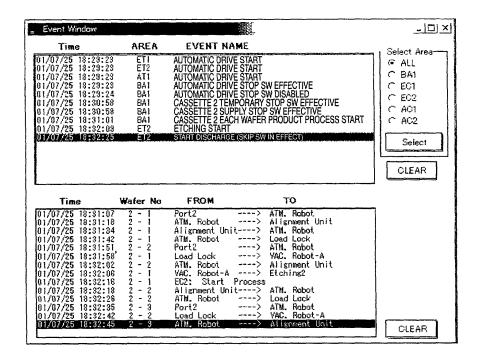


FIG. 7

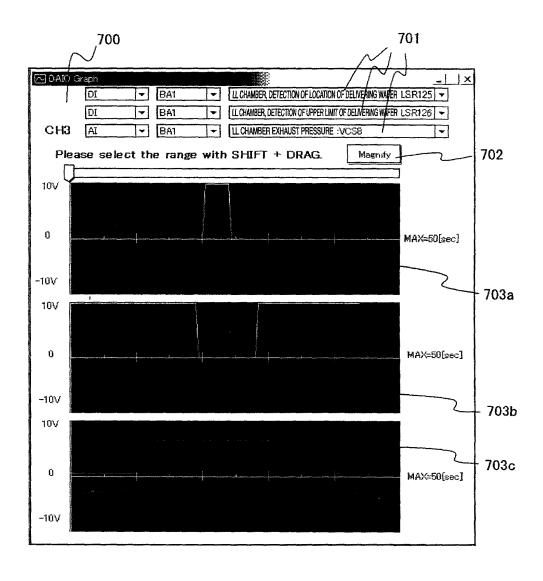
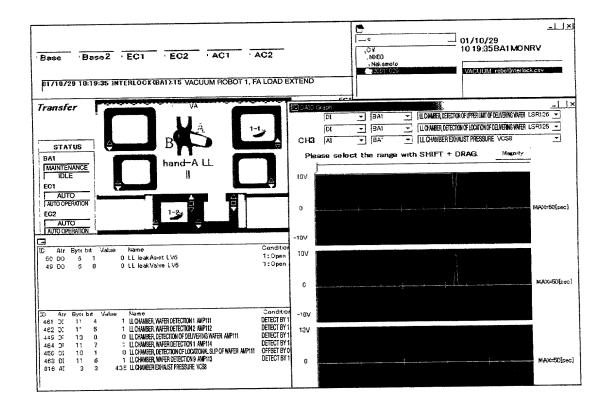


FIG. 8

<b>→</b> 10	TAB	LE						_   >
ID	Atr	Byte	bit	Value		Name	Condition	
21	DO	3	6		Ū	LP1 READY		<u> </u>
34	DO	4	1		0	LP1 HO-AVBL SMIF1 Ready to UL		<u> </u> -
32	DO	3	7		0	LP1 ES		
35	DO	4	2		0	LP1 LREQ SMIF1 Port Leck		
33	DO	4	0		Ũ	LP1 UREQ 3MIF1 Load/Unioad		
ID	Atr	Byte		1	-			
				Value	_	Name	Condition	-
415		5	Ó			LP1 TR REQ		
414		5	5		0	LP1 CS2		
409		5	0		Ü	LP1 BUSY		<u> </u>
416	DI	5	7		0	LP1 CONT		1
419	DI	5	1		0	LP1 COMPT		1
413	DI	5	4		0	LP1 GS1		
412	ÐI	5	3		0	LP1 GS0		
411	DI	5	2		0	LP1 VALID		l
								+
								·
				····				

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FIG. 9



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## FIG. 10

LIST OF OCCURRENCE ERROR CAUSES										
ERROR: TIMEOUT ERROR OF DELIVERING LOCATION OF LL CHAMBER										
LARGER										
POSSIBILITY	DELIVERING LOCATION SENSOR OF LL CHAMBER	Î								
	LOWER LIMIT LOCATION SENSOR OF LL CHAMBER									
	UPPER LIMIT LOCATION SENSOR OF LL CHAMBER									
	VACUUM DETECTION SENSOR OF LL CHAMBER									
	VACUUM GAUGE OF LL CHAMBER									
	- 1111 - 11111 - 1111 - 1111 - 1111 - 1111									